Research Article

Dielectric Properties of Two-Dimensional Bi$_2$Se$_3$ Hexagonal Nanoplates Modified PVDF Nanocomposites

Zunpeng Feng, Yanan Hao, Jiameng Zhang, Jing Qin, Limin Guo, and Ke Bi

State Key Laboratory of Information Photonics and Optical Communications, School of Science, Beijing University of Posts and Telecommunications, Beijing 100876, China

Correspondence should be addressed to Yanan Hao; hyn@bupt.edu.cn

Received 5 April 2019; Revised 21 May 2019; Accepted 13 June 2019; Published 3 July 2019

Academic Editor: Kinga Pielichowska

Copyright © 2019 Zunpeng Feng et al. This is an open access article distributed under the Creative Commons Attribution License, which permits unrestricted use, distribution, and reproduction in any medium, provided the original work is properly cited.

Topological insulator two-dimensional (2D) Bi$_2$Se$_3$ hexagonal nanoplates, which are highly insulating in the bulk and have a conductive topological surface state, have been prepared via an “EG- (ethylene glycol-) sol” method and characterized by transmission electron microscopy (TEM), X-ray diffraction (XRD), and scanning electron microscopy (SEM). Bi$_2$Se$_3$/PVDF (polyvinylidene fluoride) nanocomposites with various Bi$_2$Se$_3$ contents have been fabricated by a tape-casting method. The microstructure and dielectric performance of the Bi$_2$Se$_3$/PVDF nanocomposites are studied. The dielectric constant of the dense nanocomposite films keeps a relatively low value of about 16 when the Bi$_2$Se$_3$ content is lower than 12 vol.% then suddenly increases to 36 with a critical Bi$_2$Se$_3$ content of 13 vol.% due to the percolation effect of the large aspect ratio of the 2D Bi$_2$Se$_3$ nanoplates. The study of the Bi$_2$Se$_3$/PVDF nanocomposite system is conducive to the exploration of high-performance dielectrics.

1. Introduction

Materials with high permittivity and excellent dielectric properties have drawn extensive attention because of their growing demand in the applications of embedded capacitors, printed circuit boards (PCB) [1], microelectromechanical systems (MEMS) [2], field-effect transistors (FETs) and actuators, etc. [3]. As one of the most representative and widely used dielectric materials, ceramic-based dielectric materials have defects such as high brittleness and poor organic compatibility. Polymer-based dielectric materials have good flexibility, light weight, and good compatibility but a quite low dielectric constant (approximately 2 to 10). Therefore, a variety of high dielectric constant or conductive fillers are used to improve the dielectric properties of the polymers, such as high-$k$ ceramic nanoparticles [4], metal nanoparticles, carbon nanotubes (CNTs) [1], and graphene nanosheets (GNS) [5].

In ceramic/polymer composites, it is necessary to use a high loading of ceramic nanoparticles (over 40 vol.%) as fillers to achieve a permittivity higher than 50, while the high loading of ceramic fillers usually results in poor processability and mechanical flexibility [6]. In order to solve these problems, a feasible strategy is to blend polymers with conductive or semiconductive nanomaterials, based on the percolation effect and interfacial polarization effect [7–9]. In recent years, one-dimensional (1D) and two-dimensional (2D) carbon nanomaterials as fillers of polymer dielectric materials have been extensively studied, which are more effective than metal nanoparticles in preparing high dielectric composites [3]. For example, Dang et al. demonstrated a giant dielectric permittivity (>4000 at 1 kHz) at room temperature when the volume fraction of TFP-MWNTs is $f_{\text{TFP-MWNT}} = 0.15$; however, the dielectric constant decreases rapidly (~1000 at 10 kHz) as the frequency increases [10]. Huang et al. reported the dielectric properties and breakdown strength of PVDF/graphene ferroelectric composite films, in which the dielectric constant was lower than 150 at 1 kHz and the breakdown strength reduced very quickly with the fillings increasing [9]. Additionally, Shang et al. investigated oriented polyvinylidene fluoride nanocomposites incorporated with graphene nanosheets; a high dielectric constant of 63 is obtained at 100 Hz when the concentration of GNS is 1.27 vol.%, while the electrical breakdown strength of the composite films diminished quickly with a small filling fraction [7]. Using the highly conductive fillers, the relatively high
permittivity always decreased rapidly with increase of the frequency and the breakdown strength declined very quickly at small filler loadings. In recent years, topological insulators, which have a full insulating gap in the bulk and gapless edge or surface states, have drawn more and more attention. Utilizing the characteristics of topological insulators, it is promising to improve the dielectric constant while improving its breakdown field strength.

Topological insulators are new states of quantum matter which cannot be adiabatically connected to conventional insulators and semiconductors. These topological materials have been theoretically predicted and experimentally observed in a variety of systems, including HgTe quantum wells, Bi$_2$Te$_3$, and Bi$_2$Se$_3$ crystals [1]. Compared with zero- and one-dimensional (0D/1D) nanofillers, 2D nanofillers have a larger aspect ratio, which would improve the dielectric properties of the nanocomposites, since the high surface area and conductivity of 2D nanomaterials in conductor-insulator systems intensively increase polarization densities and interfacial polarization interphases [2, 11]. Chen et al. have demonstrated that 2D Bi$_2$Te$_3$ hexagonal nanoplates mixed with PVDF could have high permittivity (about 385 at 1 kHz with 10 vol.% loading of Bi$_2$Te$_3$) [8]. Owing to the unique bulk and surface characteristics, it is promising to obtain topological insulator/polymer composite materials with improved permittivity and enhanced breakdown strength. However, there are many kinds of topological insulators found at present, and few of them have been applied in the field of dielectric composite materials.

In this work, 2D Bi$_2$Se$_3$ hexagonal nanoplates are chosen as fillers due to their distinctive topological insulation performance and large surface-to-volume ratio. PVDF is used as the polymer matrix since it has a relatively high room temperature dielectric constant and superior ferroelectric properties. The 2D Bi$_2$Se$_3$ nanoplates are synthesized through an improved simple “EG-sol” method [14]. Oriented hexagonal Bi$_2$Se$_3$ nanoplates with a side length of 400-800 nm are obtained. The nanoplates have a good dispersibility and can be easily dispersed in polar solvents as well as the polymer matrix. To investigate the dielectric properties of Bi$_2$Se$_3$/PVDF nanocomposites, composite films with different volume fractions of Bi$_2$Se$_3$ nanoplates have been prepared. Due to the percolation effect and interfacial polarization effect, the permittivity of Bi$_2$Se$_3$/PVDF nanocomposite films has a sharp increase ($\varepsilon_r = 36$ at 1 kHz) when the loading of 2D Bi$_2$Se$_3$ hexagonal nanoplates reaches 13 vol.%. Although the breakdown strength ($E_b$) declines with the Bi$_2$Se$_3$ content, it still maintains a relatively high value ($E_b = 255$ kV/mm with 2 vol.% Bi$_2$Se$_3$) compared to the conductive fillers ($E_b \sim 60$ kV/mm with 0.3 vol.% graphene and 0.5 vol.% reduced graphene oxide) [7, 9]. The investigation of the Bi$_2$Se$_3$/PVDF nanocomposite is conducive to the application of topological insulators in the composite dielectrics.

2. Materials and Methods

2.1. Fabrication of 2D Bi$_2$Se$_3$ Nanoplates and Composites. The 2D Bi$_2$Se$_3$ nanoplates have been synthesized via an “EG-sol” method, which has been reported earlier [14, 15]. Specifically, 3 mmol bismuth nitrate pentahydrate (Bi(NO$_3$)$_3$·5H$_2$O), 4.5 mmol sodium selenite (Na$_2$SeO$_3$), and 100 ml ethylene glycol (EG) were added to a 250 ml three-neck flask containing a magnetic stirring bar with vigorous stirring followed by refluxing the blended solution at 195°C for 5 h. Then the flask was removed and cooled to room temperature. The product was washed alternately with isopropanol alcohol (IPA) and acetone several times and then dried at 60°C. The prepreparations of Bi$_2$Se$_3$/PVDF nanocomposite films with different Bi$_2$Se$_3$ filling fractions are shown in our previous tape-casting methods [16–18].

2.2. Characterization. The TEM image and selected area electron diffraction (SAED) of the Bi$_2$Se$_3$ nanoplates are characterized by a TEM (JEM-2100F, JEOL Ltd., Tokyo, Japan) at an accelerating voltage of 200 kV. The cross-sectional and surface microstructure of the composite films are determined using a SEM (MERLIN VP Compact, Zeiss Ltd., Germany) at 15 kV. XRD patterns are performed on a Bruker D8 Advance A25 X-ray diffractometer with Cu Kα radiation ($\lambda = 0.154056$ nm) at 40 kV and 200 mA. Before the electrical test, circular gold electrodes with 1 mm radius are prepared on both sides of the films by using ion sputtering equipment (SBC-12, KYKY Technology Co. Ltd., China). The frequency-dependent dielectric constant and loss of the composite films are determined using a precision impedance analyzer (E4980A; Agilent, Palo Alto, CA) at a frequency range of 1 kHz to 2 MHz. Breakdown strength of the nanocomposite films is measured on a ferroelectric test module (TF 2000 analyzer; aixACCT, Germany) at a constant frequency of 100 Hz and gradually increased voltages.

3. Results and Discussion

Figure 1 shows the XRD pattern and standard data card pattern of the Bi$_2$Se$_3$ nanoparticles. The measured XRD pattern which is presented by the upper black curve is well consistent with the below red line of standard data (PDF#89-2008). The crystal faces corresponding to different diffraction angles have been marked on top of the peaks. No other impurity diffraction peaks are found, which confirms the prepared Bi$_2$Se$_3$ nanoparticles have high purity. It is notable that the diffraction peaks corresponding to the crystal faces (0 0 6) and (1 1 6) have higher intensity than the standard card, which indicates the hexagon Bi$_2$Se$_3$ nanoparticles with a high degree of [0 0 1] preferential orientation [19].

Figures 2(a) and 2(b) show the SEM images of the Bi$_2$Se$_3$ nanoparticles, which demonstrate that the prepared Bi$_2$Se$_3$ nanoparticles have excellent dispersibility and a regular hexagon morphology. It is observed that the 2D Bi$_2$Se$_3$ hexagonal nanoplates are uniform and have a large aspect ratio. The inserted picture in Figure 2(a) is the Bi$_2$Se$_3$ suspension and the corresponding typical Tyndall effect. It reveals that the Bi$_2$Se$_3$ nanoplates can be uniformly distributed in DMF solvent, which is beneficial to the fabrication of uniform nanocomposite film.

Figures 3(a) and 3(b) show the representative TEM images of the 2D Bi$_2$Se$_3$ nanoparticles, which have a hexagonal

2 Advances in Polymer Technology
structure with edge lengths ranging from 400 to 800 nm and thicknesses of 30-70 nm. According to previous studies of Zhang et al., these nanoplates should be several QLs (quintuple layers) [15]. Figure 3(c) is a high-resolution TEM image of a Bi$_2$Se$_3$ nanoplate, which shows obvious lattice fringes and illustrates the high crystallinity. The interplanar distance measured from the lattice fringes is 3.58 ± 0.02 Å, as labeled in Figure 3(c), which corresponds well to the (1 0 1) lattice plane of Bi$_2$Se$_3$. Figure 3(d) is the SAED pattern of the Bi$_2$Se$_3$ nanoplates, which indicates the single crystallinity of the nanoplates.

The dispersion state of fillers in the polymer matrix is an important factor in terms of determining the dielectric behavior of the composite films. Figures 4(a)–4(h) show the cross-sectional SEM images of Bi$_2$Se$_3$/PVDF nanocomposite films with increasing Bi$_2$Se$_3$ volume fractions from 0 vol.% to 20 vol.%, respectively. Due to the shearing force during the preparation of the SEM sample, the cross-sectional SEM images in Figure 4 show that the nanosheets seem distributed parallel to the surface of the composite film, which is well consistent with the surface SEM result of the composite film.

Figure 5 shows the XRD pattern of several typical films. The XRD curve of pure PVDF illustrates that PVDF film has a dominant β phase and a little α phase. Additionally, XRD patterns of the Bi$_2$Se$_3$/PVDF composite films indicate stable rhombohedral Bi$_2$Se$_3$. As the content of the filler particle increases, the diffraction peaks of the composite films become more intense. Comparing to the XRD pattern of Bi$_2$Se$_3$ nanoplates, the diffraction peaks corresponding to the crystal faces (0 0 6) and (1 1 6) have higher intensity. This could be attributed to the casting effect of solution and confinement effect of Bi$_2$Se$_3$ into the polymer network [20]. In other words, Bi$_2$Se$_3$ nanoplates with [0 0 1] orientation tend to be distributed parallel to the surface of the composite film, which is not the case for Bi$_2$Te$_3$ [8]. However, according to previous literature reports, the percolation threshold of this work (13 vol.%) is larger than most of the carbon nanotubes and graphene.
loaded PVDF-based nanocomposites (generally <10 vol.%). For example, the percolation threshold of GNS/PVDF and TFP-MWNT/PVDF nanocomposites are 1.27 vol.% and 8 vol.%, respectively [7, 10]. In this case, the higher percolation threshold may be a consequence of three factors. (i) Due to the casting effect of solution, Bi₂Se₃ nanoplates tend to form preferred alignment and be distributed parallel to the surface of the composite film, which has been verified by SEM and XRD results. Therefore, the probability of contact between Bi₂Se₃ nanoplates is reduced, which makes it more difficult to form a conductive network [1]. (ii) The highly insulating Bi₂Se₃ nanoplates in the bulk obstruct the transmission of the electrons and thus more Bi₂Se₃ nanoplates are needed to provide a comparable conductive surface region. (iii) Compared with most of the carbon nanotubes and graphene fillers, aspect ratios of the prepared Bi₂Se₃ nanoplates are lower, and a smaller aspect ratio generally corresponds to a higher percolation threshold [21].

Dependence of the conductivity of the Bi₂Se₃/PVDF nanocomposite films on the BS (Bi₂Se₃) volume fraction is measured and shown in Figure 7. The conductivity values are relatively low with Bi₂Se₃ loading lower than 12 vol.%, which illustrates that the composite films are highly insulated. The slow increase of permittivity with Bi₂Se₃ loading can be ascribed to the interfacial polarization and the large aspect ratio of the Bi₂Se₃ nanocomposites. When the Bi₂Se₃ content is equal to or greater than 13 vol.%, the conductivity sharply increases. At this point, an insulator-conductor transition occurs. As topological insulator Bi₂Se₃ nanoplates are characterized by a full insulating gap in the bulk and gapless edge or surface states, the conductive edge or surface of the Bi₂Se₃ nanoplates could be considered as numerous
electrodes within a thin insulating PVDF polymer, together comprising a micro-capacitor model [22, 23]. These micro-capacitors greatly improve the macro dielectric constant. Therefore, the prepared Bi$_2$Se$_3$/PVDF composite films could act as an ideal candidate of high permittivity materials in high charge storage capacitors [24]. When the Bi$_2$Se$_3$ content is over the percolation threshold, in this work 13 vol.%, the dielectric constant continues to rise from 36 to 950 and the dielectric loss also increases from 11 to 14000 at 1 kHz. The conductivity networks have a great effect on the dielectric loss. The composite films with low Bi$_2$Se$_3$ content are still insulating materials and show low dielectric loss similarly to the PVDF matrix. With the increasing Bi$_2$Se$_3$
anoplates, the relative content of the polymer is too small to constitute an insulation system; edge or surface conductive topological insulator Bi$_2$Se$_3$ hexagonal nanoplates begin to touch each other and form conductive networks where the leakage current abruptly increases; as a result the dielectric loss increases dramatically. In addition, when the Bi$_2$Se$_3$ content of the composites is from 13 vol.% to 20 vol.%, the dielectric loss decreases with the increase of frequency because the induced space charges can difficultly follow the reversing field, leading to the reduced electronic oscillations [7]. These high-dielectric-constant and high-dielectric-loss composite films could be applied in an electromagnetic-wave absorption field [25–27].

For dielectric applications, the breakdown strength is an important parameter to evaluate the novel composite dielectric materials. Figure 8 illustrates the histogram of breakdown strength as a function of Bi$_2$Se$_3$ volume fraction. As the composite films with Bi$_2$Se$_3$ loading of 13 vol.% to 20 vol.% have too small resistance to measure their applied voltage, only the breakdown field of the films with volume fraction of 0-12 vol.% is measured. As can be seen from the histogram, the breakdown strength of pure PVDF is 315 kV/mm. The breakdown strength decreases with the increase of the Bi$_2$Se$_3$ content, which can be ascribed to the space charges introduced by the conductive edge or surface of Bi$_2$Se$_3$ nanoplates. Based on the report of Gyure and Beale [28], the reduction in breakdown strength is attributed to the agglomeration of conductive particles and short-circuiting of some regions in the nanocomposites, which causes the voltage drop sharply in regions and leads to a locally enhanced electric field. Therefore the breakdown will occur at a relatively low macroscopic electric field [29]. For this work, when the loaded Bi$_2$Se$_3$ volume fraction is low (no more than 2 vol.%), Bi$_2$Se$_3$ nanoplates are well separated by polymer and the interparticle distance is relatively large. However, as the concentration increases (greater than or equal to 4 vol.%), the Bi$_2$Se$_3$ nanoplates are close enough to

**Figure 4**: Cross-sectional SEM images of the Bi$_2$Se$_3$/PVDF nanocomposite films with Bi$_2$Se$_3$ volume fractions of (a) 0 vol.%, (b) 2 vol.%, (c) 4 vol.%, (d) 6 vol.%, (e) 8 vol.%, (f) 10 vol.%, (g) 15 vol.%, and (h) 20 vol.%. 

**Figure 5**: XRD pattern of pure PVDF film and the representative Bi$_2$Se$_3$/PVDF composite films filled with 4 vol.%, 10 vol.%, 15 vol.%, and 20 vol.% Bi$_2$Se$_3$ nanoplates.
aggregate and form large clusters to generate a short-circuit area in the composite, inducing a sharp drop in breakdown strength. It is worth noting that the breakdown strength only slightly decreases when the volume fraction of Bi$_2$Se$_3$ increases from 0 to 2 vol.%, which is different from other carbon filling composite materials, owing to the unique full insulating gap in the bulk of Bi$_2$Se$_3$ topological insulators. Owing to the macroscopically insulating behavior of the composite films with Bi$_2$Se$_3$ content up to 12 vol.%, these conductor-insulator composites can be used in capacitive and energy storage applications [30–32].

4. Conclusions

In summary, topological insulator 2D Bi$_2$Se$_3$ nanoplates with a full insulating gap in the bulk and gapless edge or surface states and PVDF blend films have been prepared. The dielectric performance of Bi$_2$Se$_3$/PVDF nanocomposite films is studied. Due to the large aspect ratio of the 2D Bi$_2$Se$_3$ nanoplates and the percolation effect, both the dielectric constant and loss of the Bi$_2$Se$_3$/PVDF nanocomposite films maintain a relatively low value with the Bi$_2$Se$_3$ content lower than 12 vol.% and drastically increase with the Bi$_2$Se$_3$ content.

Figure 6: Frequency dependence of (a) dielectric constant and (b) dielectric loss of the Bi$_2$Se$_3$/PVDF nanocomposite films with different composition. (c) BS (Bi$_2$Se$_3$) content dependence of dielectric constant and dielectric loss of the Bi$_2$Se$_3$/PVDF nanocomposite films, measured at room temperature and 1 kHz.
higher than 13 vol.%. A giant dielectric constant of 950 is obtained at 1 kHz with 20 vol.% Bi₂Se₃ loading, which is 110 times that of the pure PVDF film. In addition, the breakdown strength of the composites has been investigated and the sharp drop in the electrical breakdown strength depending upon the concentration of the Bi₂Se₃ nanoplates is attributed to agglomeration effects. The Bi₂Se₃/PVDF nanocomposite films constitute a novel type of topological insulator-based composite materials and are conducive to the investigation of high-performance dielectrics.

Data Availability

The data used to support the findings of this study are included within the article.

Conflicts of Interest

The authors declare that there are no conflicts of interest regarding the publication of this paper.

Acknowledgments

This work was supported by the National Natural Science Foundation of China (Grant Nos. 51802023, 61774020, and 51802021), Young Elite Scientists Sponsorship Program by CAST (Grant No. 2018QNRC001), Science and Technology Plan of Shenzhen City (Grant No. 201887776), Fund of IOPC BUPT (Grant No. IOPC2017ZT06), and State Key Laboratory of New Ceramic and Fine Processing, Tsinghua University (No. KF201803).

References


[10] Z. Dang, L. Wang, Y. Yin, Q. Zhang, and Q. Lei, "Giant dielectric permittivities in functionalized carbon-nanotube/


